Notice of References Cited Application/Control No. 10/517,536 Applicant(s)/Patent Under Reexamination VAN BEEK ET AL. Examiner Arun Williams 2809 Applicant(s)/Patent Under Reexamination VAN BEEK ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,104,166	08-2000	Kikuchi et al.	320/132
*	В	US-5,589,755	12-1996	Kaite et al.	320/160
*	С	US-3,622,857	11-1971	Sethi, Indar K.	320/130
*	D	US-5,600,226	02-1997	. Falcon, Carl B.	320/129
*	Ε	US-4,297,630	10-1981	Mullersman, Ferdinand H.	320/150
*	F	US-6,043,630	03-2000	Koenck et al.	320/128
	G	US-			
	Н	US-			
	1	US-		·	
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Р					
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	R					
	S					
	T		,			

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	x	

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